FCC PART 15C
TEST REPORT

BLUETOOTH LOW ENERGY (BLE) PART

No. I19Z70351-IOT02

for

Samsung Electronics. Co., Ltd.

Mobile phone

Model Name: SM-S111DL,SM-A015U1

FCC ID: ZCASMS111DL

with

Hardware Version: REV3.0

Software Version: S111DL.001(S111DLUDE0ATB3),

A015U1.001(A015U1UEE0ATC2)

Issued Date: 2020-3-25

Note:

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REPORT HISTORY

Report Number	Revision	Description	Issue Date
I19Z70351-IOT02	Rev.0	1st edition	2020-3-25

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1. Test Laboratory

1.1. Introduction &Accreditation

Telecommunication Technology Labs, CAICT is an ISO/IEC 17025:2005accredited test laboratory under NATIONAL VOLUNTARY LABORATORY ACCREDITATION PROGRAM (NVLAP)with lab code600118-0, and is also an FCC accredited test laboratory (CN5017), and ISED accredited test laboratory (CN0066). The detail accreditation scope can be found on NVLAP website.

1.2. Testing Location

Conducted testing Location: CTTL(huayuan North Road)

Address: No. 52, Huayuan North Road, Haidian District, Beijing, P. R. China100191

Radiated testing Location: CTTL(Shouxiang)

Address: No. 51 Shouxiang Science Building, Xueyuan Road, Haidian District, Beijing, P. R. China100191

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1.3. Testing Environment

Normal Temperature: 15-35℃

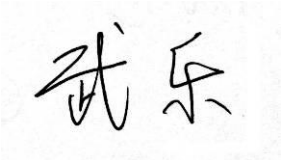
Relative Humidity: 20-75%

1.4. Project data

Testing Start Date: 2019-10-21

Testing End Date: 2020-3-10

1.5. Signature



Wu Le

(Prepared this test report)

Sun Zhenyu

(Reviewed this test report)

Li Zhuofang

(Approved this test report)

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2. Client Information

2.1. Applicant Information

Company Name:	Samsung Electronics. Co., Ltd.
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Contact Person	Jenni Chun
Contact Email	j1.chun@samsung.com
Telephone:	+1-201-937-4203
Fax:	/

2.2. Manufacturer Information

Company Name:	Samsung Electronics. Co., Ltd.
Address:	Samsung R5, Maetan dong 129, Samsung ro Youngtong gu, Suwon city 443 742, Korea
Contact Person	JP KIM
Contact Email	jp426.kim@samsung.com
Telephone:	+82-10-4376-0326
Fax:	/

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3. Equipment Under Test (EUT) and Ancillary Equipment (AE)

3.1. About EUT

Description	Mobile phone
Model Name	SM-S111DL,SM-A015U1
FCC ID	ZCASMS111DL
Frequency Band	ISM 2400MHz~2483.5MHz
Type of Modulation(LE mode)	GFSK (Bluetooth Low Energy)
Number of Channels(LE mode)	40
Power Supply	3.85V DC by Battery

3.2. Internal Identification of EUT

EUT ID*	SN or IMEI	HW Version	SW Version
EUT3	/	REV3.0	S111DL.001(S111DLUDE0ATB3), A015U1.001(A015U1UEE0ATC2)
EUT5 (SM-S111DL)	352656110007757	REV3.0	S111DL.001(S111DLUDE0ATB3)

*EUT ID: is used to identify the test sample in the lab internally.

3.3. Internal Identification of AE

AE ID*	Description	
AE1	Battery	Inbuilt
AE3	Charger	/
AE6	USB Cable	/

AE1

Model	QL1695
Manufacturer	Ningde Amperex Technology Limited
Capacitance	/
Nominal voltage	3.85 V

AE3

Model	EP-TA50JWE
Manufacturer	DongYang E&P Inc.
Length of cable	/

AE6

Model	ECB-DU68WE
Manufacturer	SHENGHUA
Length of cable	/

*AE ID: is used to identify the test sample in the lab internally.

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3.4. EUT set-ups

EUT set-up No.	Combination of EUT and AE	Remarks
Set.11	EUT3+ AE1+ AE3+ AE6	WIFI&BT

3.5. Normal Accessory setting

Fully charged battery is used during the test.

3.6. General Description

The Equipment Under Test (EUT) is a model of Mobile phone with integrated antenna. It consists of normal options: lithium battery, charger. Manual and specifications of the EUT were provided to fulfill the test. Samples undergoing test were selected by the Client.

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4. Reference Documents

4.1. Documents supplied by applicant

EUT feature information is supplied by the client or manufacturer, which is the basis of testing.

4.2. Reference Documents for testing

The following documents listed in this section are referred for testing.

Reference	Title	Version
FCC Part15	FCC CFR 47, Part 15, Subpart C: 15.205 Restricted bands of operation; 15.209 Radiated emission limits, general requirements; 15.247 Operation within the bands 902–928MHz, 2400–2483.5 MHz, and 5725–5850 MHz.	2018
ANSI C63.10	American National Standard of Procedures for Compliance Testing of Unlicensed Wireless Devices	June,2013

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5. Test Results

5.1. Summary of Test Results

Abbreviations used in this clause:

P Pass, The EUT complies with the essential requirements in the standard.

F Fail, The EUT does not comply with the essential requirements in the standard

NA Not Applicable, The test was not applicable

NP Not Performed, The test was not performed by CTTL

R Re-use test data from basic model report.

SUMMARY OF MEASUREMENT RESULTS	Sub-clause	Verdict
6dB Bandwidth	15.247 (a)(2)	**R**
Peak Output Power - Conducted	15.247 (b)(1)	**P**
Maximum Power Spectral Density Level	15.247(e)	**R**
Transmitter Spurious Emission - Conducted	15.247 (d)	**R**
Transmitter Spurious Emission - Radiated	15.247, 15.205, 15.209	**R**
Frequency Band Edges	15.247 (d)	**R**
AC Powerline Conducted Emission	15.107, 15.207	**R**

Please refer to **ANNEX A** for detail.

The measurement is made according to ANSI C63.10.

5.2. Statements

CTTL has evaluated the test cases requested by the applicant /manufacturer as listed in section 5.1 of this report for the EUT specified in section 3 according to the standards or reference documents listed in section 4.2

5.3. Explanation of re-use of test data

The Equipment Under Test (EUT) model SM-S111DL and SM-A015U1(FCC ID: ZCASMS111DL) are variants product of SM-A015T1(FCC ID: ZCASMA015T1), according to the declaration of changes provided by the applicant and FCC KDB publication 484596 D01, spot check measurements(Peak Output Power-Conducted) were performed on SM-S111DL(The SM-S111DL is a new product for this testing. The SM-A015U1 is a variant product of SM-S111DL and shares the SM-S111DL results.), other test results are derived from test report No. I19Z70303-IOT12. (I19Z70303-IOT12 is test report of SM-A015V. SM-A015T1 is a variant product of SM-A015V and shares the SM-A015V results.)Please refer Annex A for detail spot check verification data and reference data. the spot check test results are consistent with basic model.

For detail differences between two models please refer the Declaration of Changes document.

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6. Test Facilities Utilized

Conducted test system

No.	Equipment	Model	Serial Number	Manufacturer	Calibration Period	Calibration Due date
1	Vector Signal Analyzer	FSQ26	200136	Rohde & Schwarz	1 year	2020-11-29
2	Bluetooth Tester	CBT32	101042	Rohde & Schwarz	1 year	2020-11-29
3	LISN	ENV216	101200	Rohde & Schwarz	1 year	2020-04-28
4	Test Receiver	ESCI	100344	Rohde & Schwarz	1 year	2021-02-27
5	Shielding Room	S81	/	ETS-Lindgren	/	/

Radiated emission test system

No.	Equipment	Model	Serial Number	Manufacturer	Calibration Period	Calibration Due date
1	Test Receiver	ESU26	100235	Rohde & Schwarz	1 year	2021-03-03
2	BiLog Antenna	VULB9163	1222	Schwarzbeck	1 year	2020-03-14
3	Dual-Ridge Waveguide Horn Antenna	3115	6914	ETS-Lindgren	1 year	2021-01-03

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7. Measurement Uncertainty

7.1. Peak Output Power - Conducted

Measurement Uncertainty:

Measurement Uncertainty (k=2)	0.66dB

7.2. Frequency Band Edges

Measurement Uncertainty:

Measurement Uncertainty (k=2)	0.66dB

7.3. Transmitter Spurious Emission - Conducted

Measurement Uncertainty:

Frequency Range	Uncertainty (k=2)
30 MHz ~ 8 GHz	1.22dB
8 GHz ~ 12.75 GHz	1.51dB
12.7GHz ~ 26 GHz	1.51dB

7.4. Transmitter Spurious Emission - Radiated

Measurement Uncertainty:

Frequency Range	Uncertainty (k=2)
＜ 1 GHz	4.86dB
＞ 1 GHz	5.26dB

7.5. 6dB Bandwidth

Measurement Uncertainty:

Measurement Uncertainty (k=2)	61.936Hz

7.6. Maximum Power Spectral Density Level

Measurement Uncertainty:

Measurement Uncertainty (k=2)	0.66dB

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7.7. AC Powerline Conducted Emission

Measurement Uncertainty:

Measurement Uncertainty (k=2)	3.38dB

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ANNEX A: Detailed Test Results

A.1. Measurement Method

A.1.1. Conducted Measurements

The measurement is made according to ANSI C63.10.

1). Connect the EUT to the test system correctly.

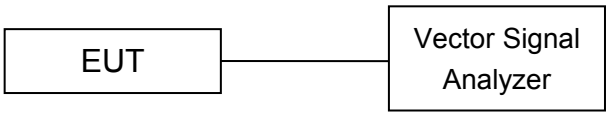
2). Set the EUT to the required work mode (Transmitter, receiver or transmitter & receiver).

3). Set the EUT to the required channel.

4). Set the EUT hopping mode (hopping or hopping off).

5). Set the spectrum analyzer to start measurement.

6). Record the values. Vector Signal Analyzer



A.1.2. Radiated Emission Measurements

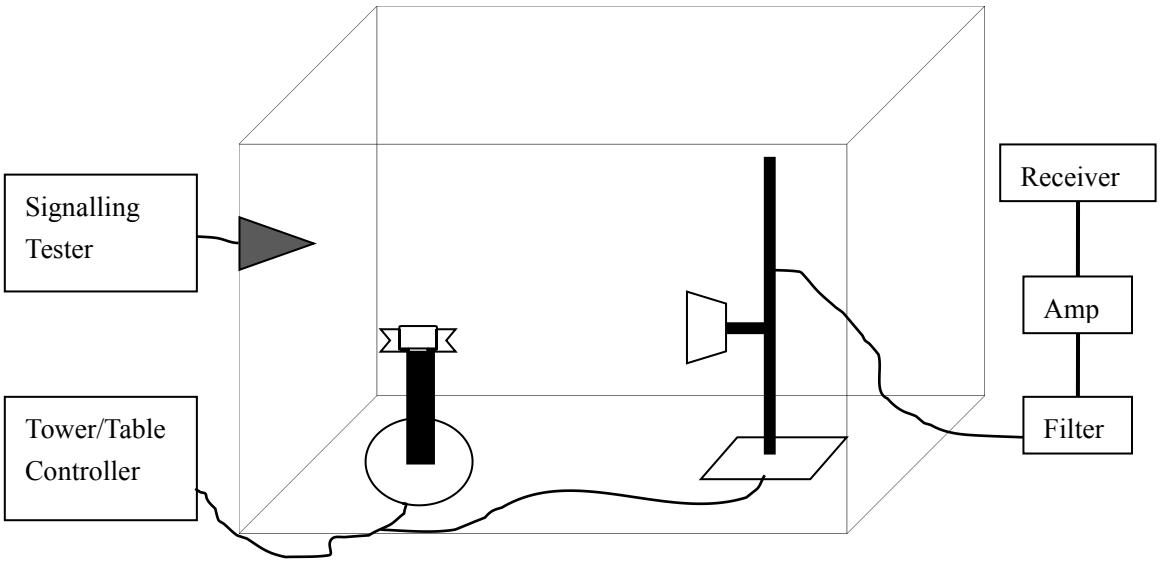
The measurement is made according to ANSI C63.10.

The radiated emission test is performed in semi-anechoic chamber. The distance from the EUT to the reference point of measurement antenna is 3m. The test is carried out on both vertical and horizontal polarization and only maximization result of both polarizations is kept. During the test, the turntable is rotated 360° and the measurement antenna is moved from 1m to 4m to get the maximization result.

In the case of radiated emission, the used settings are as follows,

Sweep frequency from 30 MHz to 1GHz, RBW = 100 kHz, VBW = 300 kHz;

Sweep frequency from 1 GHz to 26GHz, RBW = 1MHz, VBW = 1MHz;



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A.2. Peak Output Power - Conducted

Method of Measurement: See ANSI C63.10-clause 11.9.1.1

a) Set the RBW = 1 MHz.
b) Set VBW = 3 MHz.
c) Set span = 3 MHz.
d) Sweep time = auto couple.
e) Detector = peak.
f) Trace mode = max hold.
g) Allow trace to fully stabilize.
h) Use peak marker function to determine the peak amplitude level.

Measurement Limit:

Standard	Limit (dBm)
FCC Part 15.247(b)(3)	< 30

Spot check Measurement Results:

Channel No.	Frequency (MHz)	Peak Conducted Output Power (dBm)	Conclusion
0	2402	-2.86	P
19	2440	-1.60	P
39	2480	-2.55	P

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Reference Measurement Results from basic model:

For GFSK

Channel No.	Frequency (MHz)	Peak Conducted Output Power (dBm)	Conclusion
0	2402	-2.53	P
19	2440	-1.44	P
39	2480	-1.87	P

Conclusion: PASS

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A.3. Frequency Band Edges - Conducted

Method of Measurement: See ANSI C63.10-clause 6.10.4

Connect the spectrum analyzer to the EUT using an appropriate RF cable connected to the EUT output. Configure the spectrum analyzer settings as described below.

a) Set Span = 8MHz
b) Sweep Time: Auto
c) Set the RBW= 100 kHz
c) Set the VBW= 300 kHz
d) Detector: Peak
e) Trace: Max hold

Observe the stored trace and measure the amplitude delta between the peak of the fundamental and the peak of the band-edge emission. This is not an absolute field strength measurement; it is only a relative measurement to determine the amount by which the emission drops at the band edge relative to the highest fundamental emission level.

Measurement Limit:

Standard	Limit (dBc)
FCC 47 CFR Part 15.247 (d)	< -20

Measurement Result:

For GFSK

Channel No.	Frequency (MHz)	Hopping	Band Edge Power (dBc)		Conclusion
0	2402	Hopping OFF	Fig.1	-53.39	P
39	2480	Hopping OFF	Fig.2	-53.82	P

Conclusion: PASS

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Test graphs as below

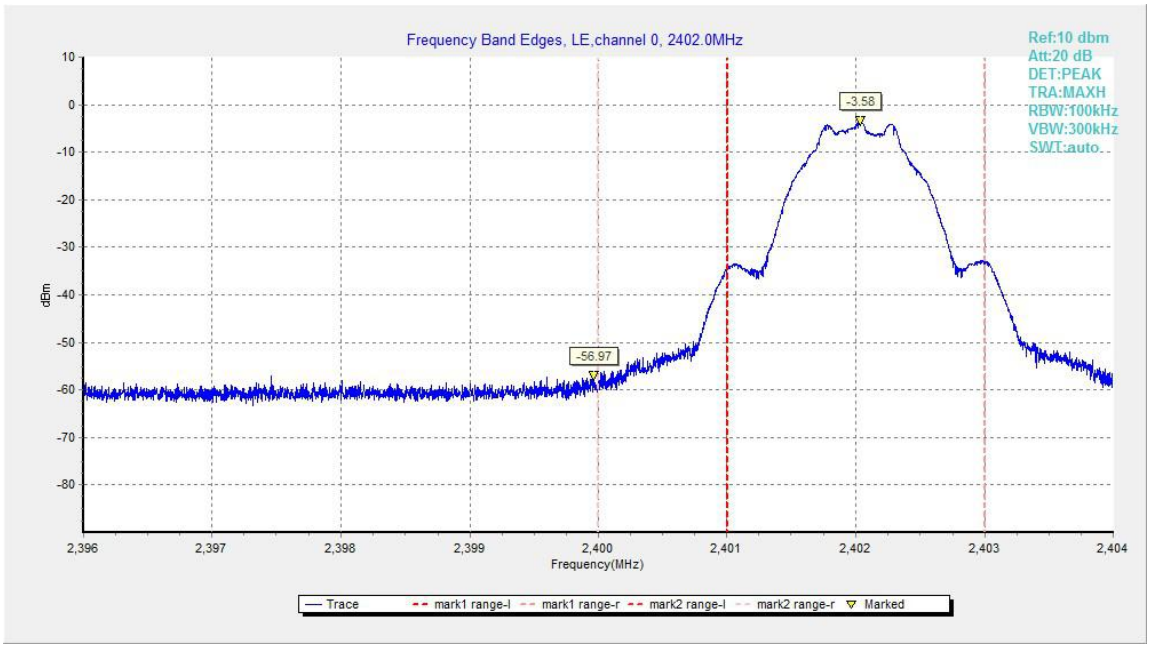

Fig.1. Frequency Band Edges: GFSK, 2402 MHz, Hopping Off

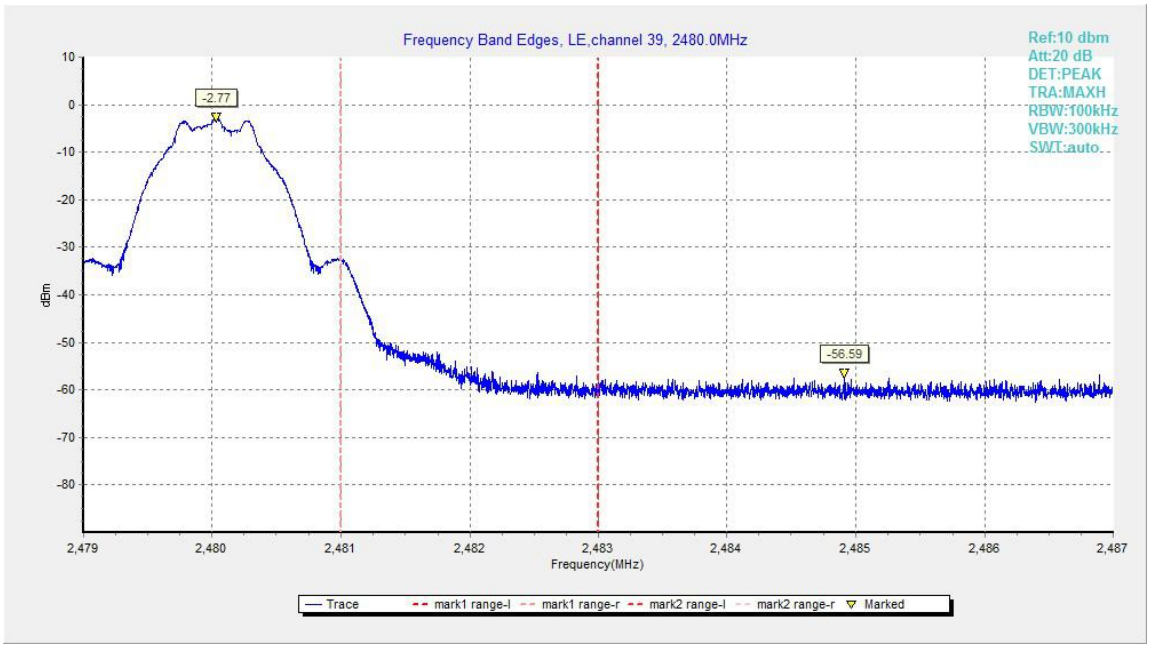

Fig.2. Frequency Band Edges: GFSK, 2480 MHz, Hopping Off

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A.4. Transmitter Spurious Emission - Conducted

Method of Measurement: See ANSI C63.10-clause 11.11.2 and clause 11.11.3

Measurement Procedure – Reference Level

1. Set the RBW = 100 kHz.
2. Set the VBW = 300 kHz.
3. Set the span to ⩾1.5 times the DTS bandwidth.
4. Detector = peak.
5. Sweep time = auto couple.
6. Trace mode = max hold.
7. Allow trace to fully stabilize.
8. Use the peak marker function to determine the maximum PSD level. Next, determine the power in 100 kHz band segments outside of the authorized frequency band using the following measurement:

Measurement Procedure - Unwanted Emissions

1. Set RBW = 100 kHz.
2. Set VBW = 300 kHz.
3. Set span to encompass the spectrum to be examined.
4. Detector = peak.
5. Trace Mode = max hold.
6. Sweep = auto couple.
7. Allow the trace to stabilize (this may take some time, depending on the extent of the span).

Ensure that the amplitude of all unwanted emissions outside of the authorized frequency band (excluding restricted frequency bands) is attenuated by at least the minimum requirements specified above.

Measurement Limit:

Standard	Limit
FCC 47 CFR Part 15.247 (d)	20dB below peak output power in 100 kHz bandwidth

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Measurement Results:

For GFSK

Channel No.	Frequency (MHz)	Frequency Range	Test Results	Conclusion
0	2402	Center Frequency	Fig.3	P
		30 MHz ~ 1 GHz	Fig.4	P
		1 GHz ~ 3 GHz	Fig.5	P
		3 GHz ~ 10 GHz	Fig.6	P
		10GHz ~ 26 GHz	Fig.7	P
19	2440	Center Frequency	Fig.8	P
		30 MHz ~ 1 GHz	Fig.9	P
		1 GHz ~ 3 GHz	Fig.10	P
		3 GHz ~ 10 GHz	Fig.11	P
		10GHz ~ 26 GHz	Fig.12	P
39	2480	Center Frequency	Fig.13	P
		30 MHz ~ 1 GHz	Fig.14	P
		1 GHz ~ 3GHz	Fig.15	P
		3 GHz ~ 10 GHz	Fig.16	P
		10 GHz ~ 26 GHz	Fig.17	P

Conclusion: PASS

Test graphs as below

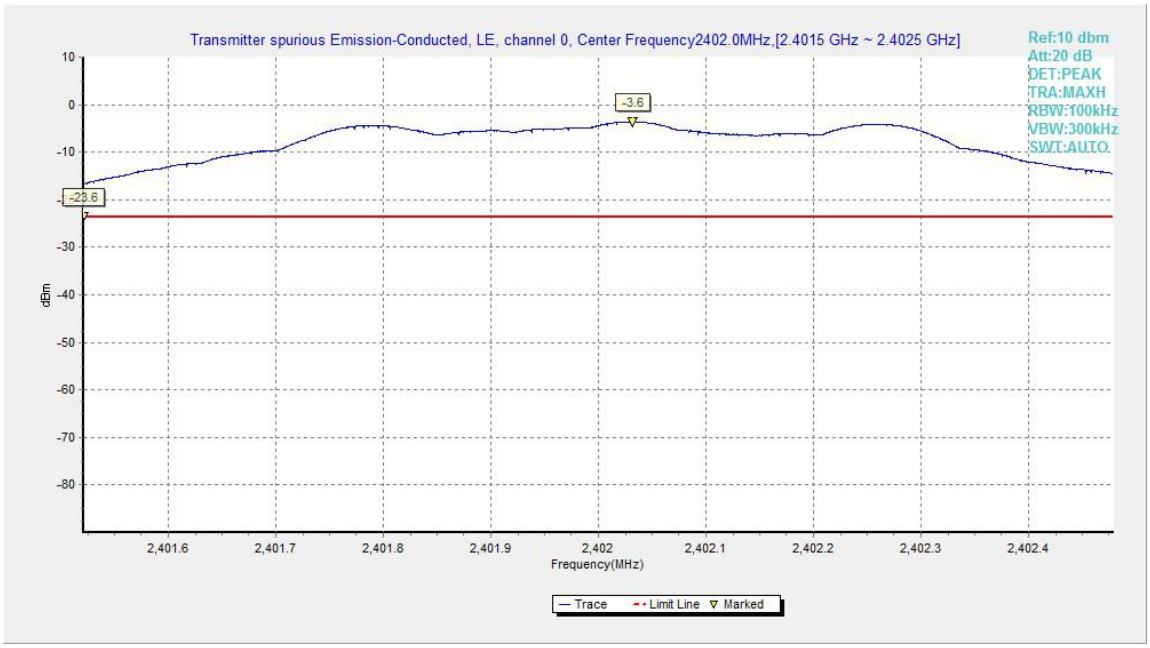

Fig.3. Transmitter Spurious Emission - Conducted: GFSK,2402MHz

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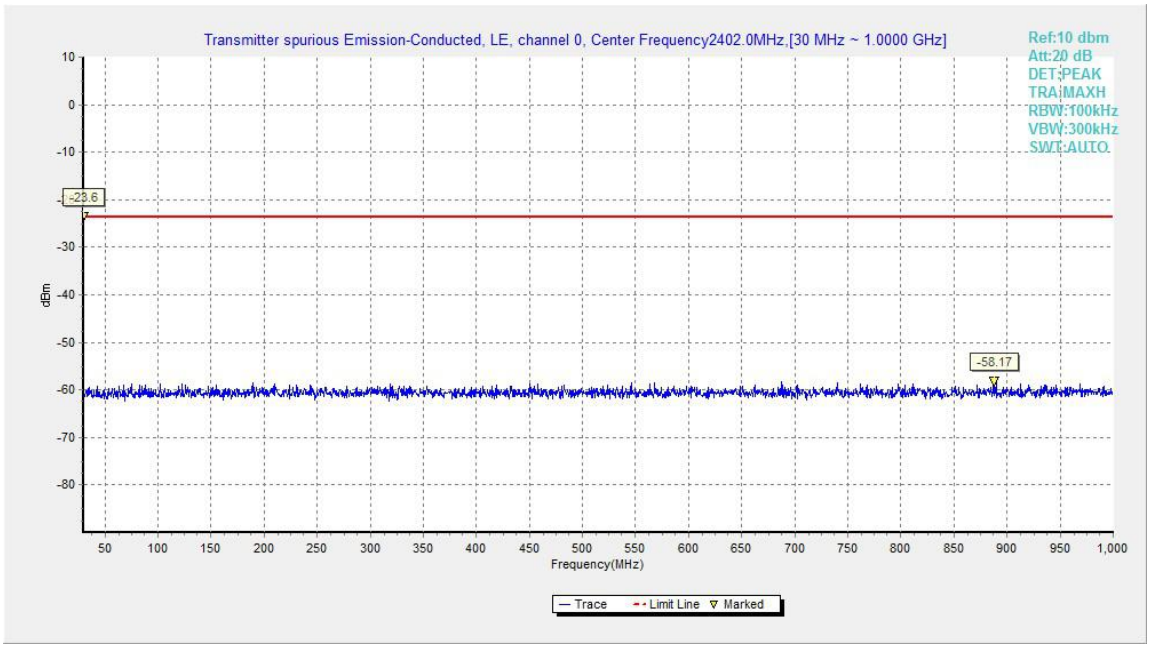

Fig.4. Transmitter Spurious Emission - Conducted: GFSK, 2402 MHz, 30MHz - 1GHz

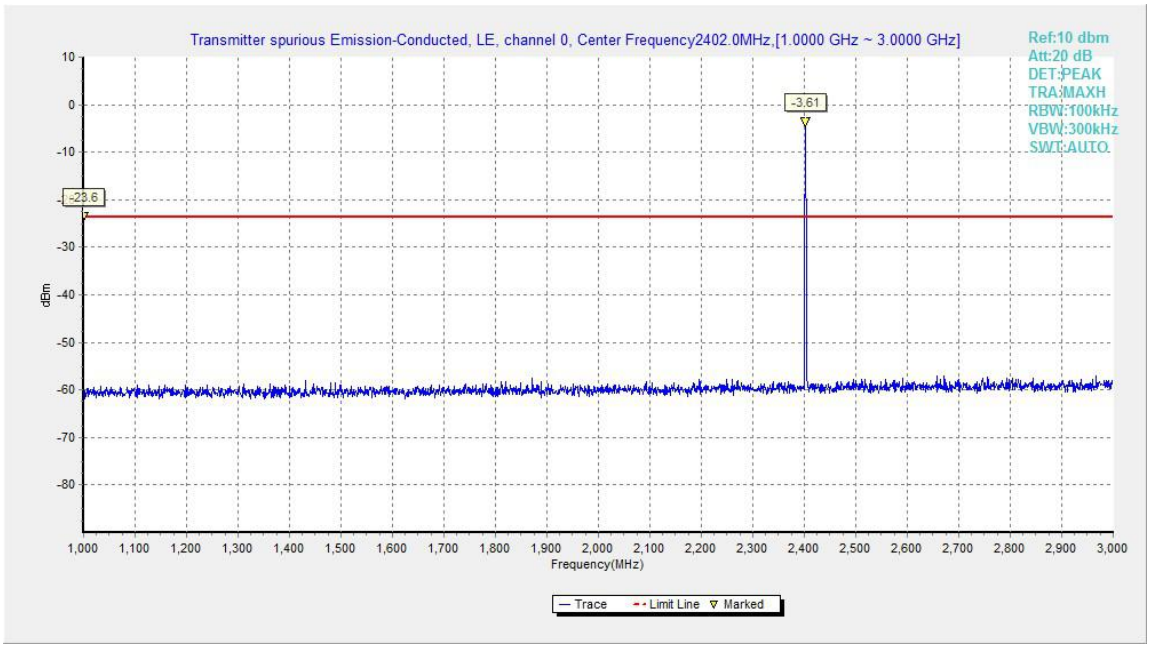

Fig.5. Transmitter Spurious Emission - Conducted: GFSK, 2402 MHz,1GHz - 3GHz

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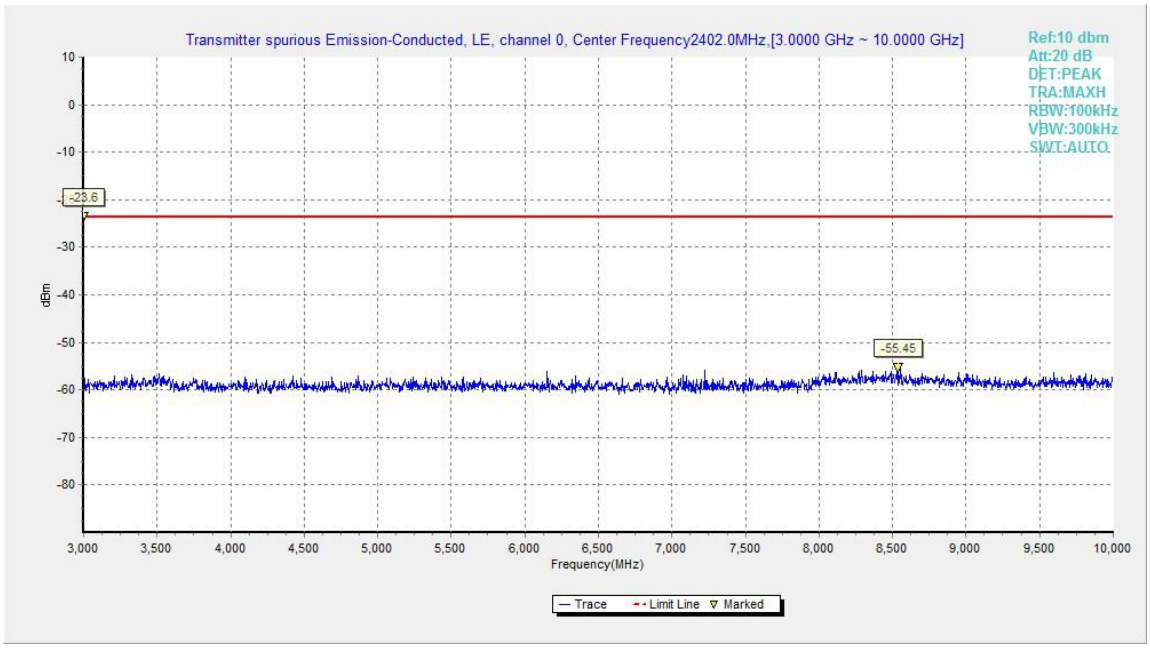

Fig.6. Transmitter Spurious Emission - Conducted: GFSK, 2402 MHz,3GHz - 10GHz

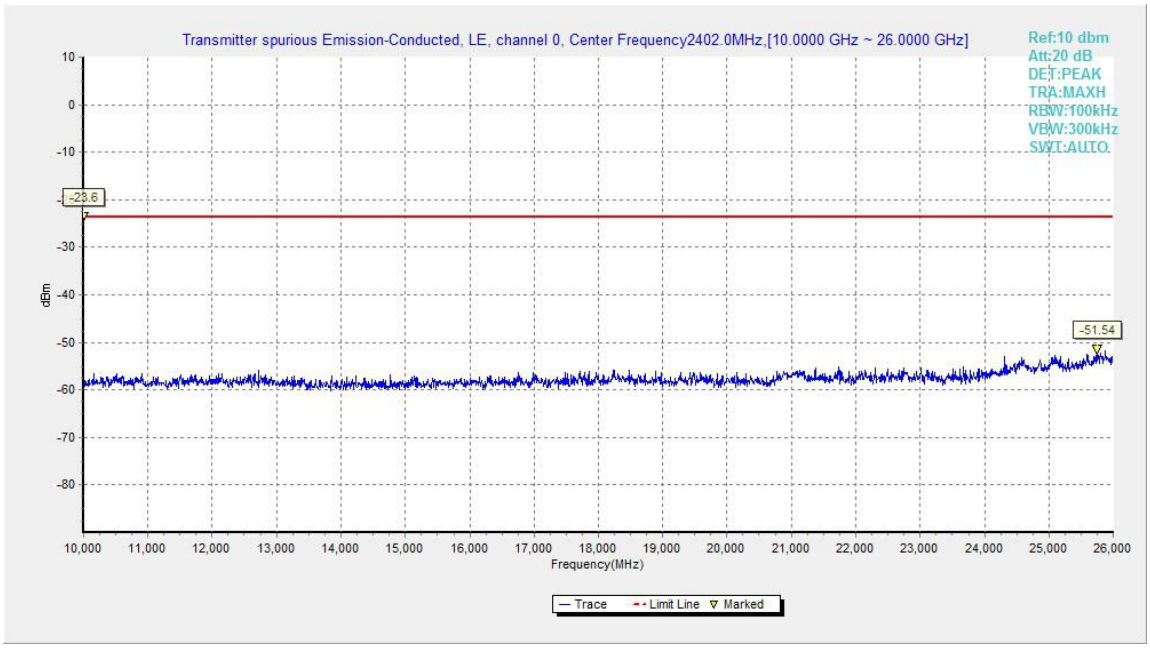

Fig.7. Transmitter Spurious Emission - Conducted: GFSK, 2402 MHz,10GHz - 26GHz

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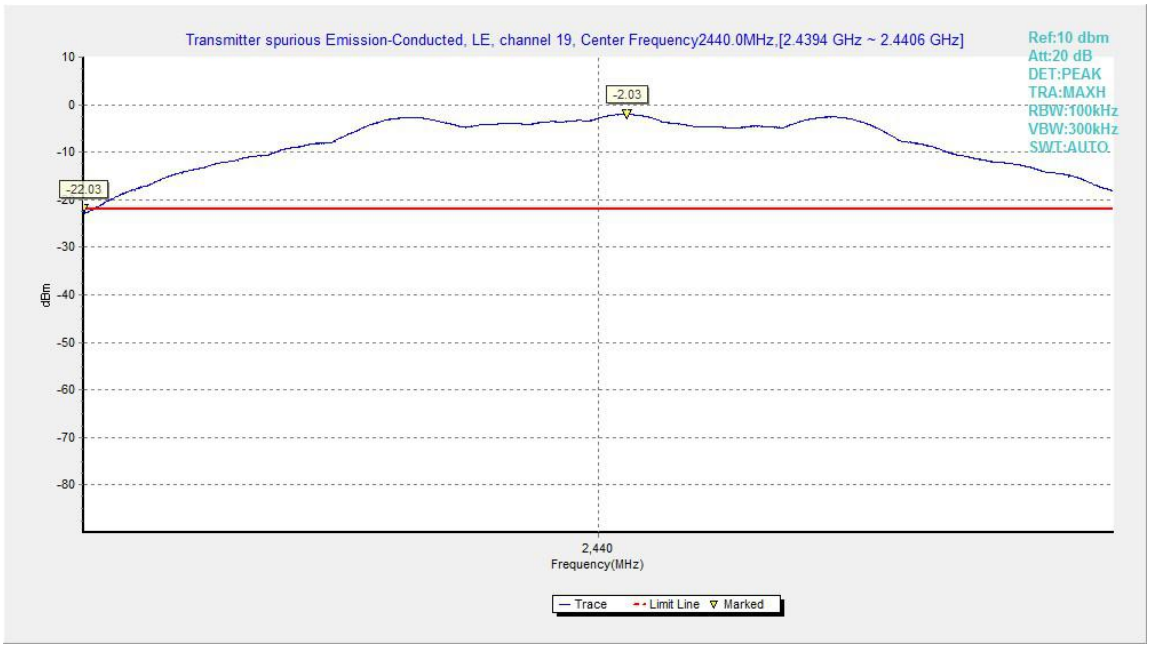

Fig.8. Transmitter Spurious Emission - Conducted: GFSK, 2440MHz

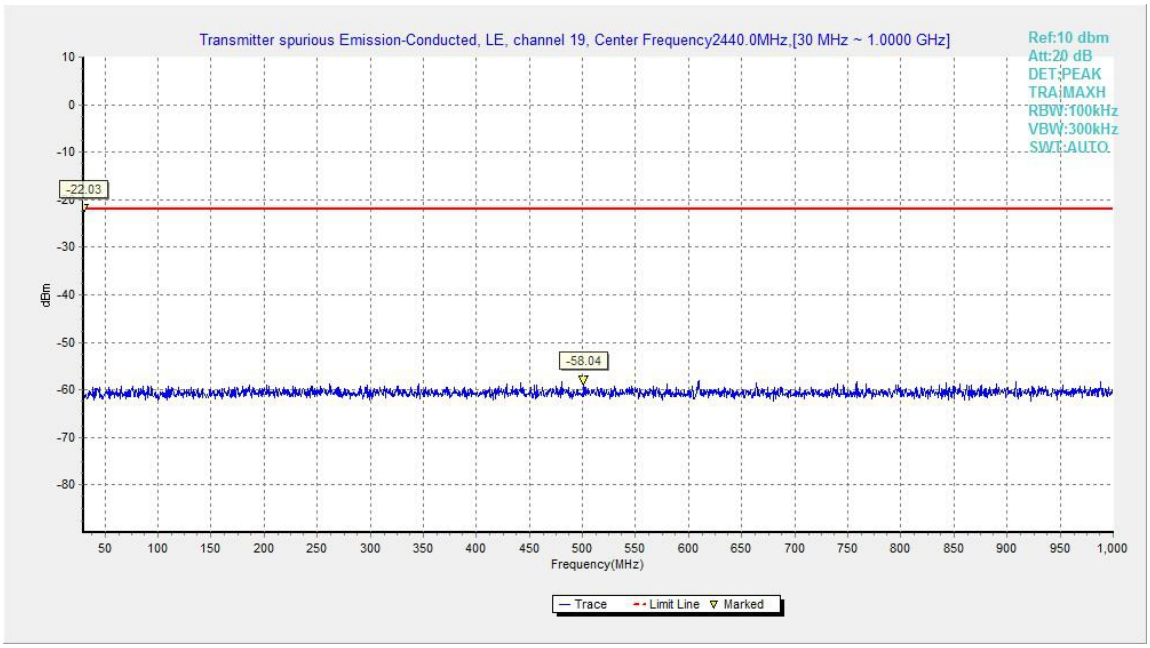

Fig.9. Transmitter Spurious Emission - Conducted: GFSK, 2440 MHz, 30MHz - 1GHz

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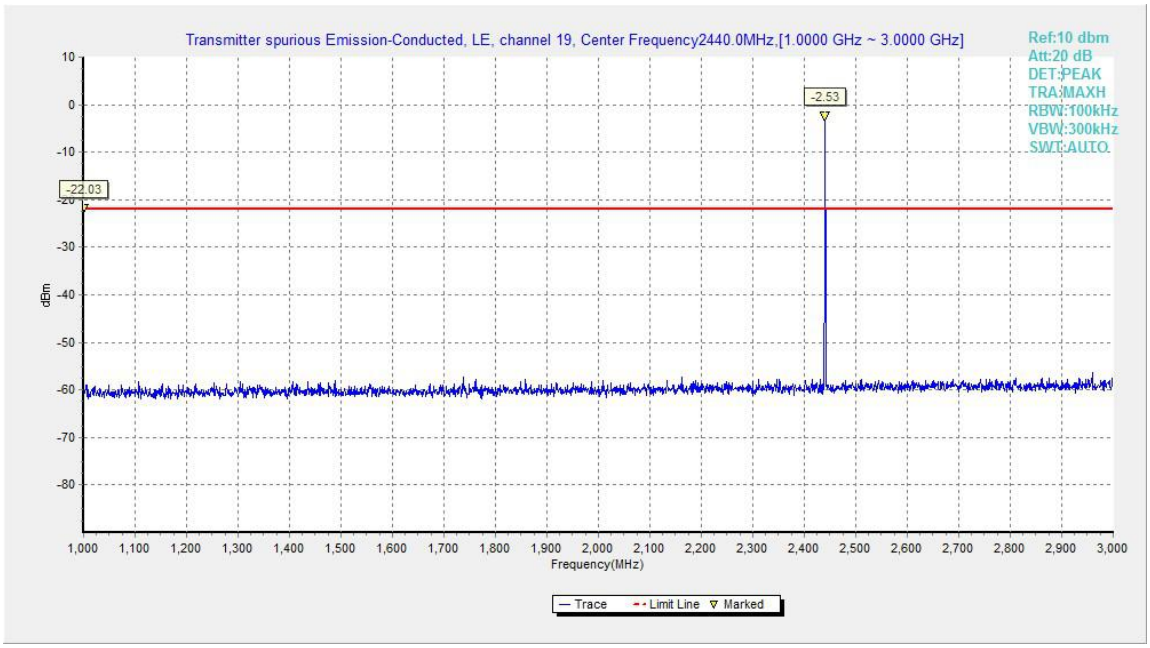

Fig.10. Transmitter Spurious Emission - Conducted: GFSK, 2440 MHz, 1GHz – 3GHz

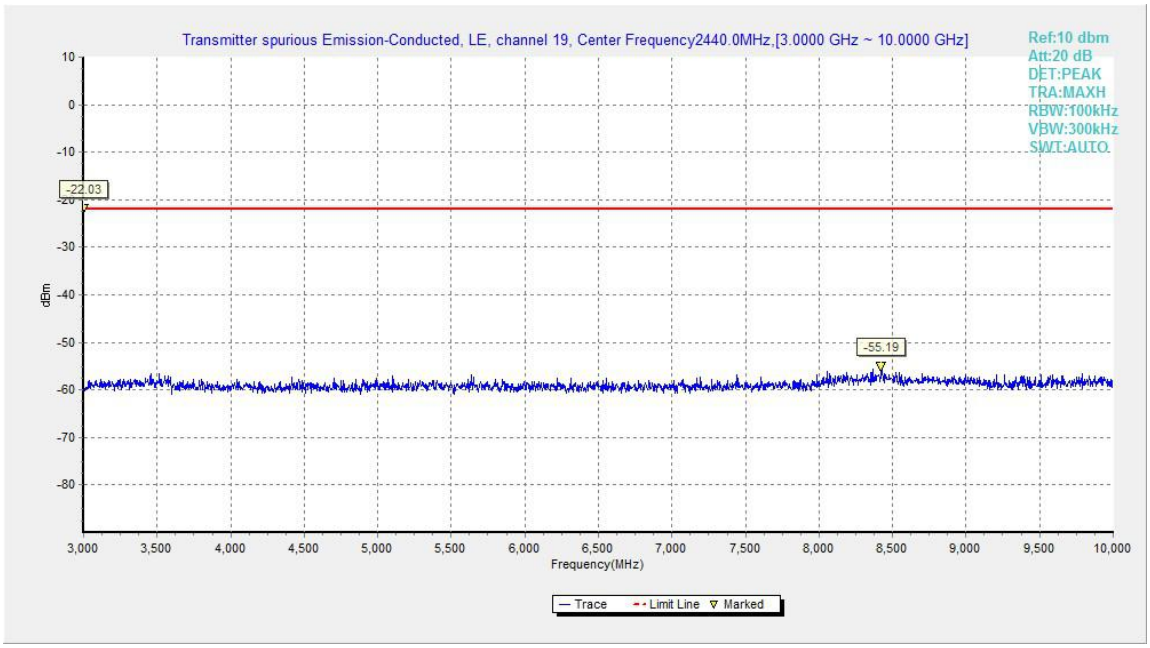

Fig.11. Transmitter Spurious Emission - Conducted: GFSK, 2440 MHz, 3GHz – 10GHz

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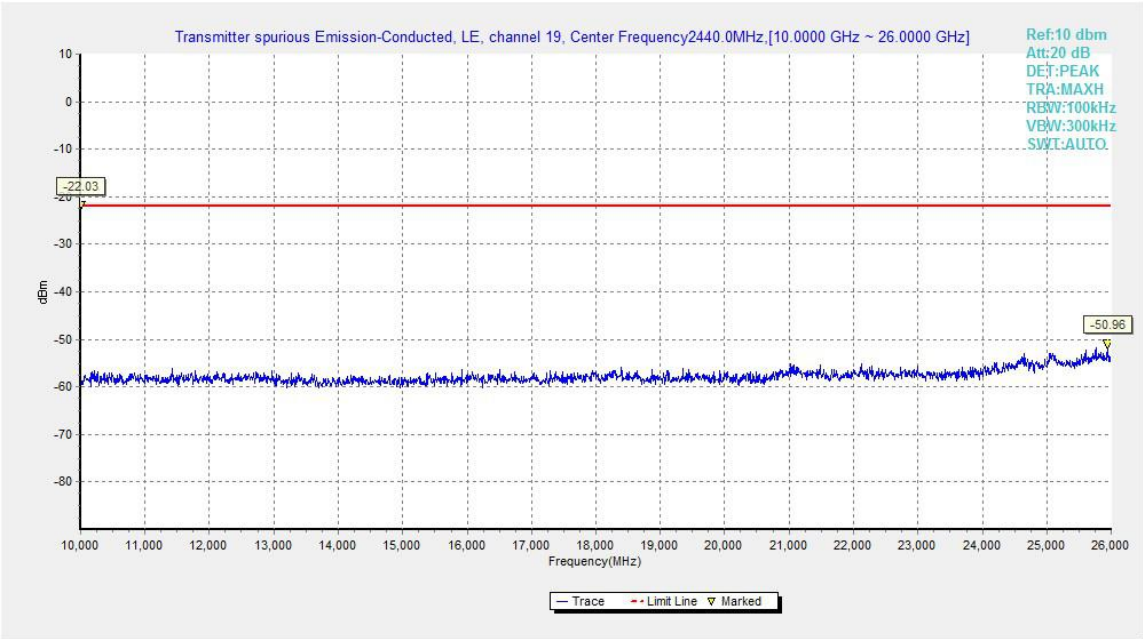

Fig.12. Transmitter Spurious Emission - Conducted: GFSK, 2440 MHz, 10GHz – 26GHz

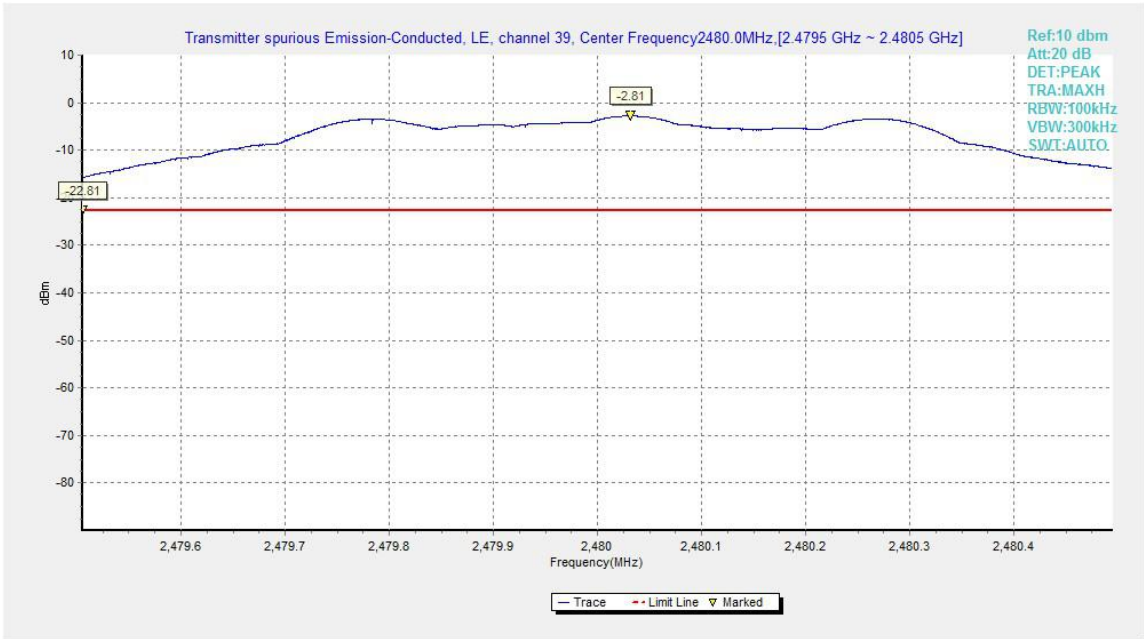

Fig.13. Transmitter Spurious Emission - Conducted: GFSK, 2480 MHz

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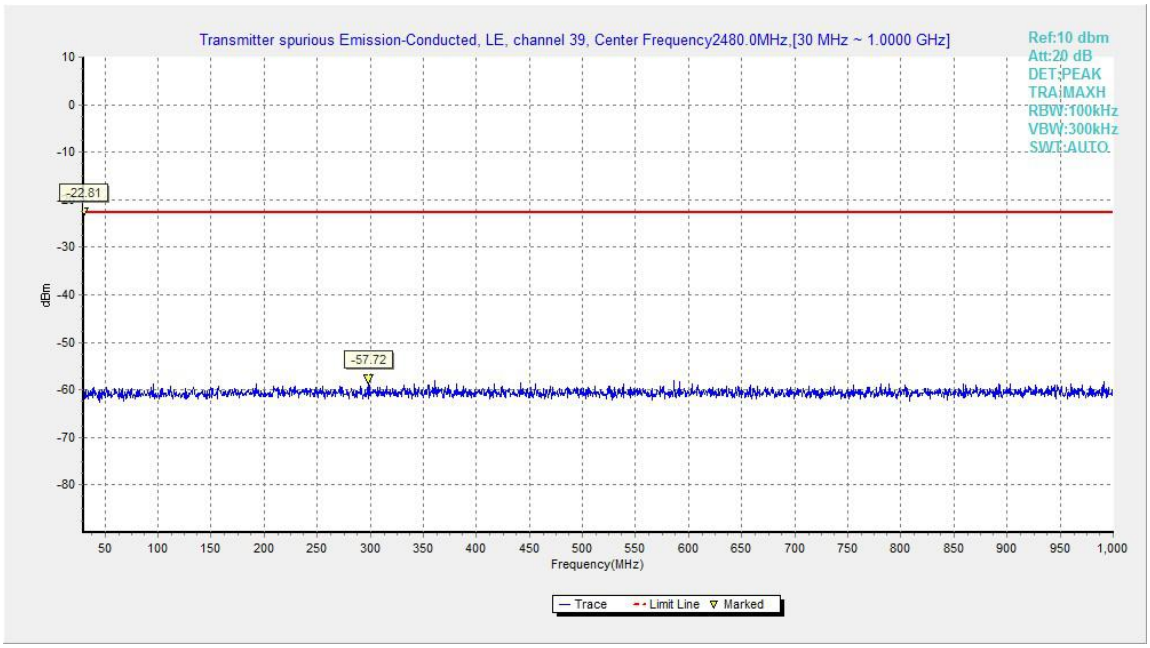

Fig.14. Transmitter Spurious Emission - Conducted: GFSK, 2480 MHz, 30MHz - 1GHz

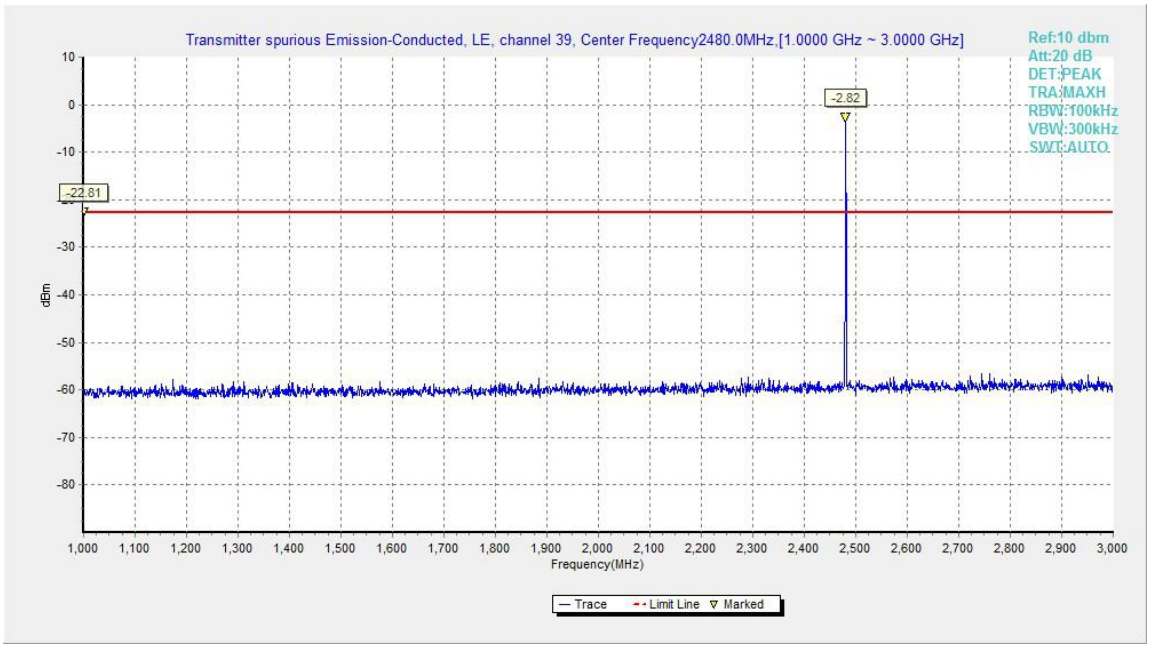

Fig.15. Transmitter Spurious Emission - Conducted: GFSK, 2480 MHz, 1GHz - 3GHz

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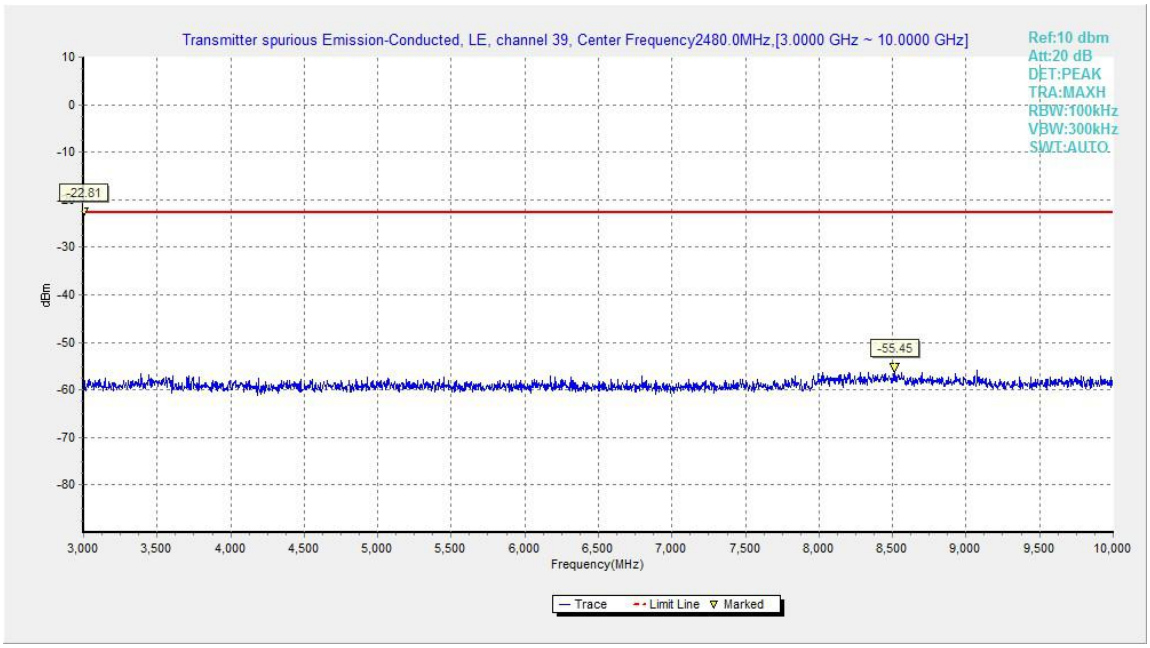

Fig.16. Transmitter Spurious Emission - Conducted: GFSK, 2480 MHz, 3GHz - 10GHz

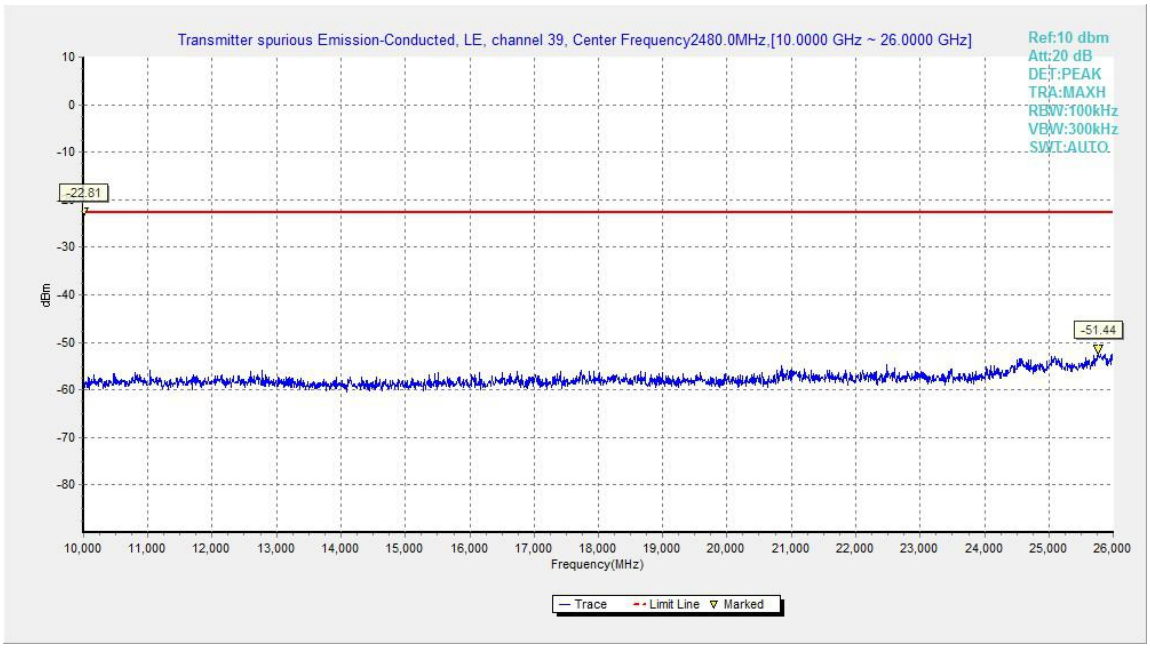

Fig.17. Transmitter Spurious Emission - Conducted: GFSK, 2480 MHz, 10GHz - 26GHz

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A.5. Transmitter Spurious Emission - Radiated

Measurement Limit:

Standard	Limit
FCC 47 CFR Part 15.247, 15.205, 15.209	20dB below peak output power

In addition, radiated emissions which fall in the restricted bands, as defined in § 15.205(a), must also comply with the radiated emission limits specified in § 15.209(a) (see § 15.205(c)).

The measurement is made according to ANSI C63.10

Limit in restricted band:

Frequency of emission (MHz)	Field strength(uV/m)	Field strength(dBuV/m)
30-88	100	40
88-216	150	43.5
216-960	200	46
Above 960	500	54

Test Condition

The EUT was placed on a non-conductive table. The measurement antenna was placed at a distance of 3 meters from the EUT. During the tests, the antenna height and the EUT azimuth were varied in order to identify the maximum level of emissions from the EUT. This maximization process was repeated with the EUT positioned in each of its three orthogonal orientations.

Frequency of emission (MHz)	RBW/VBW	Sweep Time(s)
30-1000	100KHz/300KHz	5
1000-4000	1MHz/3MHz	15
4000-18000	1MHz/3MHz	40
18000-26500	1MHz/3MHz	20

Measurement Results:

A "reference path loss" is established and the A_{Rpl} is the attenuation of “reference path loss”, and including the gain of receive antenna, the gain of the preamplifier, the cable loss.

The measurement results are obtained as described below:

Measurement Results for Set.11:

Result=P_{Mea}+A_{Rpl}

For BT BLE

Frequency	Frequency Range	Test Results	Conclusion
Power	2.31GHz~2.43GHz---L	Fig.18	P
Power	2.45GHz~2.50GHz---H	Fig.19	P

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BT BLE 2402MHz–Average

Frequency (MHz)	Measurement Result (dBμV/m)	Cable loss (dB)	Antenna Factor (dB/m)	Receiver Reading (dBμV)	Antenna Pol. (H/V)
17985.0	37.0	-25.5	43.4	19.1	V
17995.5	36.9	-25.5	43.4	19.0	V
17889.0	36.8	-25.5	43.4	18.9	V
17994.0	36.8	-25.5	43.4	18.9	V
17997.0	36.8	-25.5	43.4	18.9	V
2388.7	39.5	-14.2	27.2	26.5	H

BT BLE 2440MHz–Average

Frequency (MHz)	Measurement Result (dBμV/m)	Cable loss (dB)	Antenna Factor (dB/m)	Receiver Reading (dBμV)	Antenna Pol. (H/V)
17979.0	36.7	-25.5	43.4	18.8	H
17971.5	36.5	-25.5	43.4	18.6	V
17878.5	36.4	-25.5	43.4	18.5	V
17977.5	36.4	-25.5	43.4	18.5	V
17980.5	36.4	-25.5	43.4	18.5	V
17982.0	36.4	-25.5	43.4	18.5	H

BT BLE 2480MHz–Average

Frequency (MHz)	Measurement Result (dBμV/m)	Cable loss (dB)	Antenna Factor (dB/m)	Receiver Reading (dBμV)	Antenna Pol. (H/V)
17982.0	36.6	-25.5	43.4	18.7	V
17988.0	36.6	-25.5	43.4	18.7	H
17994.0	36.6	-25.5	43.4	18.7	V
17872.5	36.5	-25.5	43.4	18.6	V
17890.5	36.5	-25.5	43.4	18.6	H
2492.0	39.6	-14.2	27.2	26.6	V

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BT BLE 2402MHz–Peak

Frequency (MHz)	Measurement Result (dBμV/m)	Cable loss (dB)	Antenna Factor (dB/m)	Receiver Reading (dBμV)	Antenna Pol. (H/V)
17703.0	49.8	-25.7	43.4	32.1	V
17832.0	49.5	-25.5	43.4	31.6	V
17587.5	48.8	-25.7	43.4	31.1	V
17892.0	48.8	-25.5	43.4	30.9	V
17907.0	48.8	-25.5	43.4	30.9	H
2381.6	52.7	-14.2	27.2	39.7	H

BT BLE 2440MHz–Peak

Frequency (MHz)	Measurement Result (dBμV/m)	Cable loss (dB)	Antenna Factor (dB/m)	Receiver Reading (dBμV)	Antenna Pol. (H/V)
17893.5	49.1	-25.5	43.4	31.2	H
17980.5	49.0	-25.5	43.4	31.1	V
17905.5	48.6	-25.5	43.4	30.7	H
17961.0	48.6	-25.5	43.4	30.7	V
17743.5	48.4	-25.5	43.4	30.5	V
17919.0	48.4	-25.5	43.4	30.5	H

BT BLE 2480MHz–Peak

Frequency (MHz)	Measurement Result (dBμV/m)	Cable loss (dB)	Antenna Factor (dB/m)	Receiver Reading (dBμV)	Antenna Pol. (H/V)
17722.5	49.7	-25.7	43.4	32.0	V
17955.0	49.0	-25.5	43.4	31.1	V
17884.5	48.9	-25.5	43.4	31.0	V
17692.5	48.7	-25.7	43.4	31.0	V
17850.0	48.7	-25.5	43.4	30.8	V
2494.5	52.4	-14.2	27.2	39.4	V

Conclusion: PASS

Test graphs as below:

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Result for Set.11:

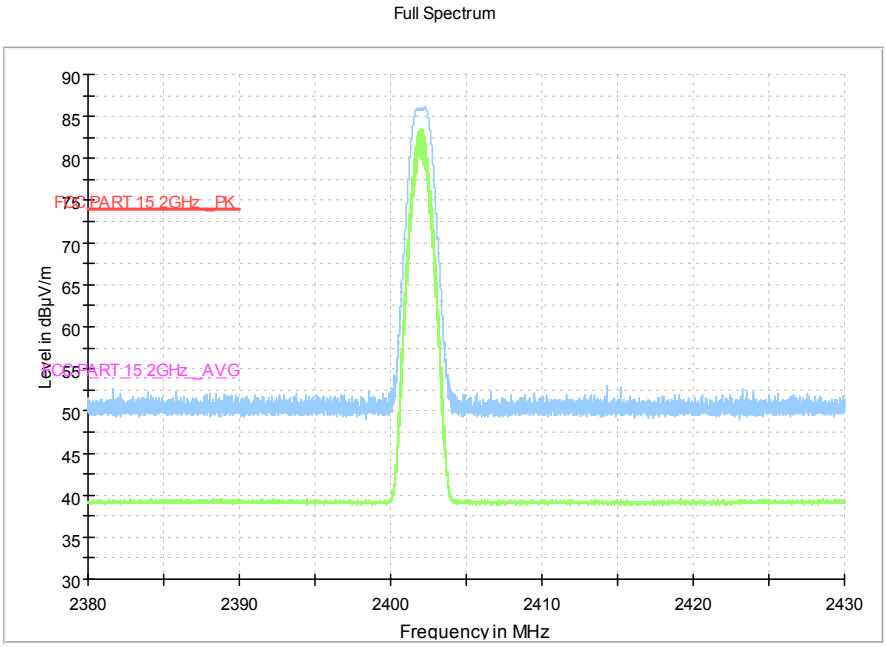

Fig.18. Transmitter Spurious Emission - Radiated (Power): BT BLE low channel

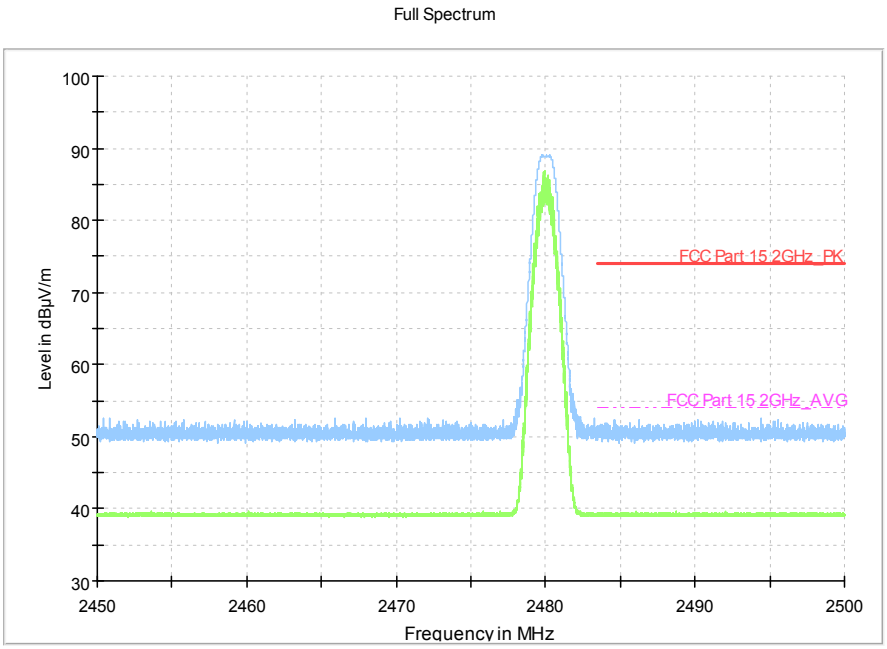

Fig.19. Transmitter Spurious Emission - Radiated (Power): BT BLE high channel

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A.6. 6dB Bandwidth

Method of Measurement:

The measurement is made according to ANSI C63.10 clause 11.8.1
1.Set RBW = 100 kHz.
2. Set the video bandwidth (VBW) = 300 kHz.
3. Detector = Peak.
4. Trace mode = max hold.
5. Sweep = auto couple.
6. Allow the trace to stabilize.
7. Measure the maximum width of the emission that is constrained by the frequencies associated with the two outermost amplitude points (upper and lower frequencies) that are attenuated by 6 dB relative to the maximum level measured in the fundamental emission.

Measurement Limit:

Standard	Limit
FCC 47 CFR Part 15.247(a)(2)	>= 500KHz

Measurement Results:

For GFSK

Channel No.	Frequency (MHz)	6dB Bandwidth (kHz)		Conclusion
0	2402	Fig.20	681.00	P
19	2440	Fig.21	680.00	P
39	2480	Fig.22	691.50	P

Conclusion: PASS

Test graphs as below:

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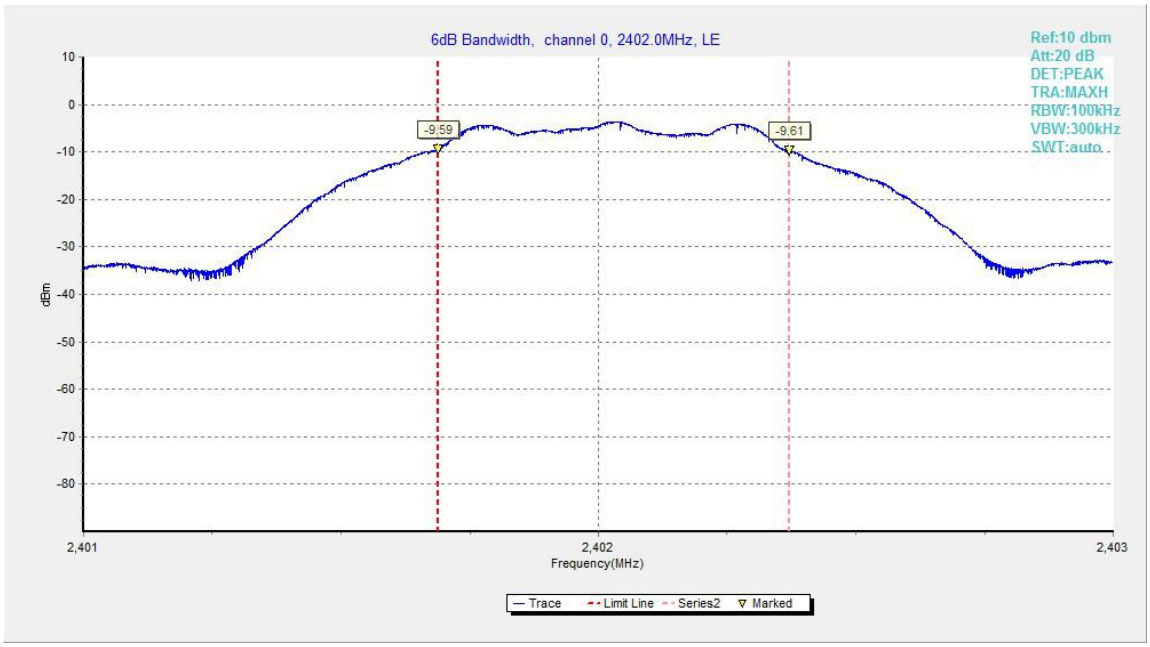

Fig.20. 6dB Bandwidth: GFSK, 2402 MHz

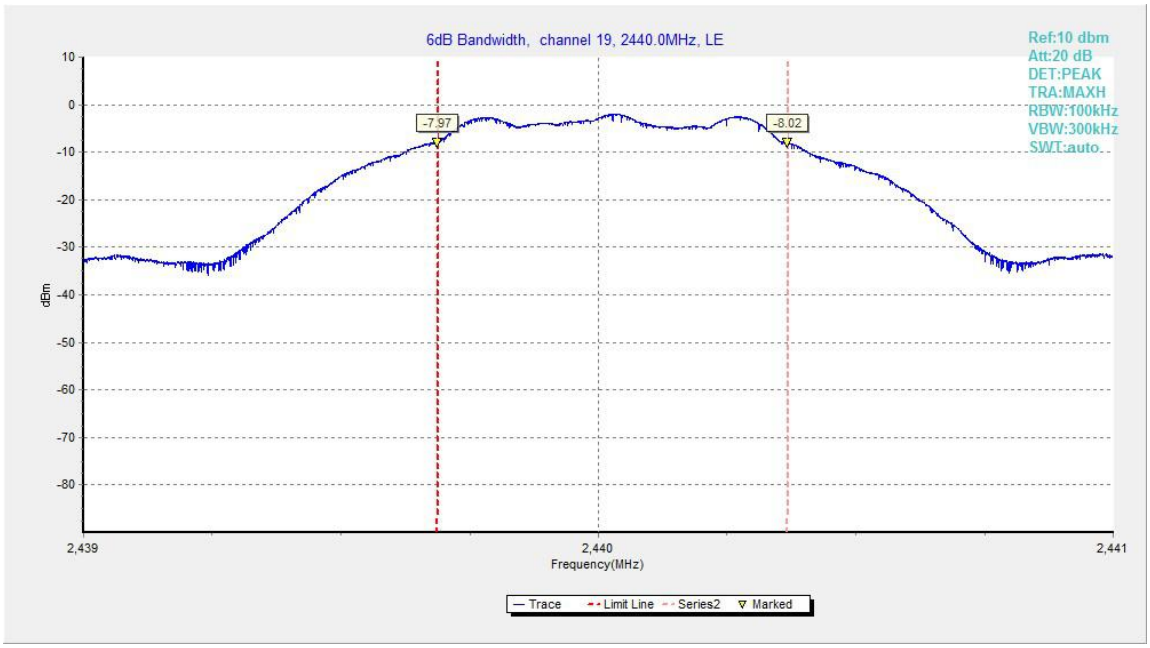

Fig.21. 6dB Bandwidth: GFSK, 2440 MHz

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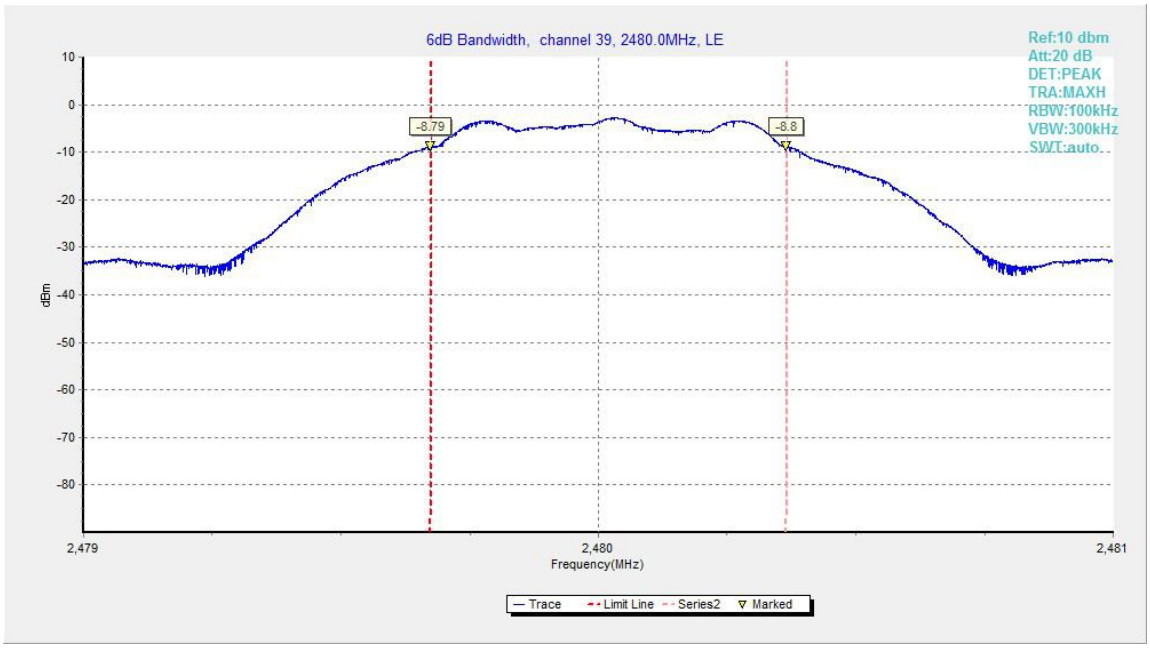

Fig.22. 6dB Bandwidth: GFSK, 2480 MHz

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A.7. Maximum Power Spectral Density Level

Method of Measurement:

The measurement is made according to ANSI C63.10 clause 11.10.2

1. Set the RBW = 3 kHz.
2. Set the VBW = 10 kHz.
3. Set the span to 2 times the DTS bandwidth.
4. Detector = peak.
5. Sweep time = auto couple.
6. Trace mode = max hold.
7. Allow trace to fully stabilize.
8. Use the peak marker function to determine the maximum amplitude level within the RBW.

Measurement Limit:

Standard	Limit
FCC 47 CFR Part 15.247(e)	<=8.0dBm/3kHz

Measurement Results:

For GFSK

Channel No.	Frequency (MHz)	Maximum Power Spectral Density Level(dBm/3kHz)		Conclusion
0	2402	Fig.23	-18.74	P
19	2440	Fig.24	-17.14	P
39	2480	Fig.25	-17.90	P

Test graphs as below:

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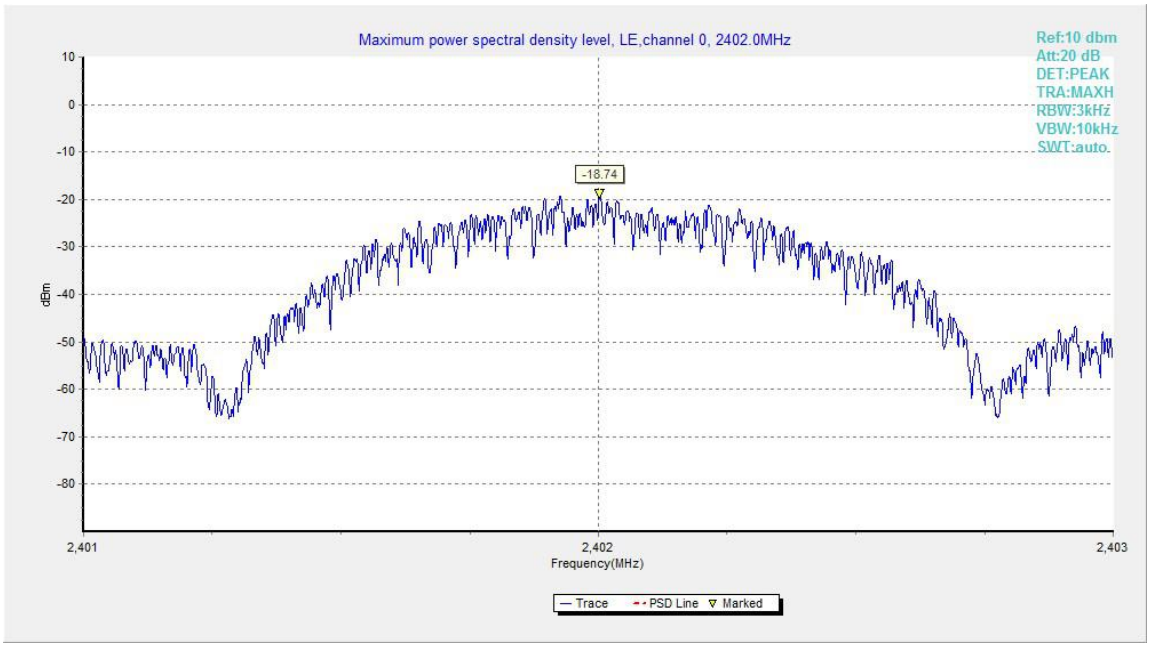

Fig.23. Maximum Power Spectral Density Level Function: GFSK, 2402 MHz

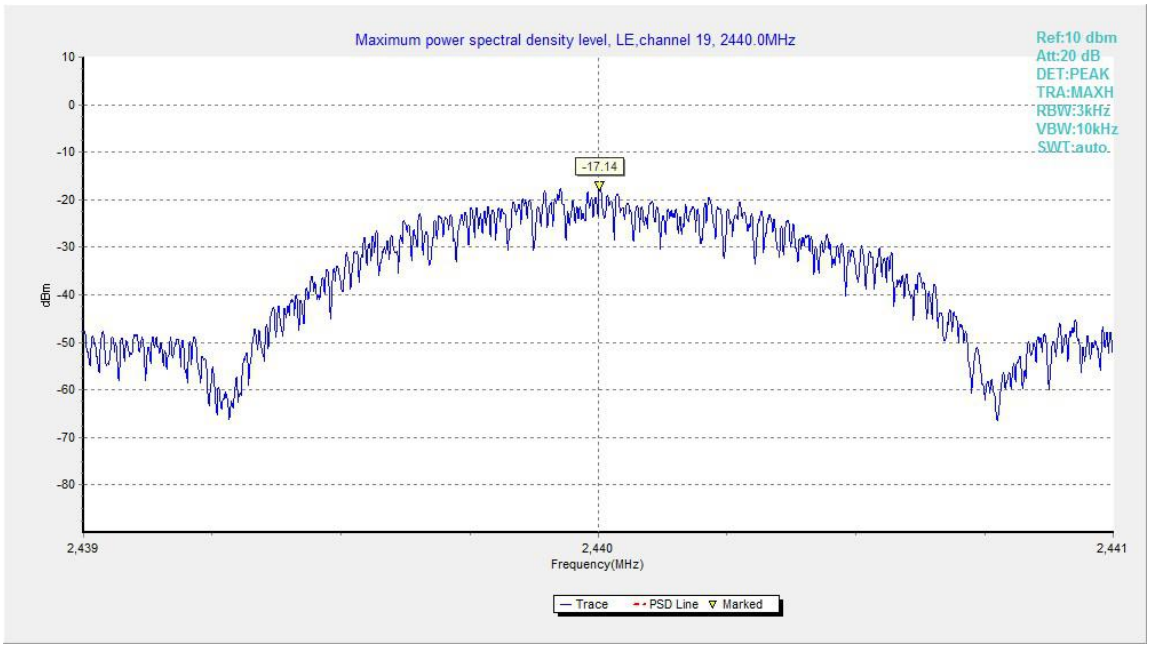

Fig.24. Maximum Power Spectral Density Level Function: GFSK, 2440 MHz

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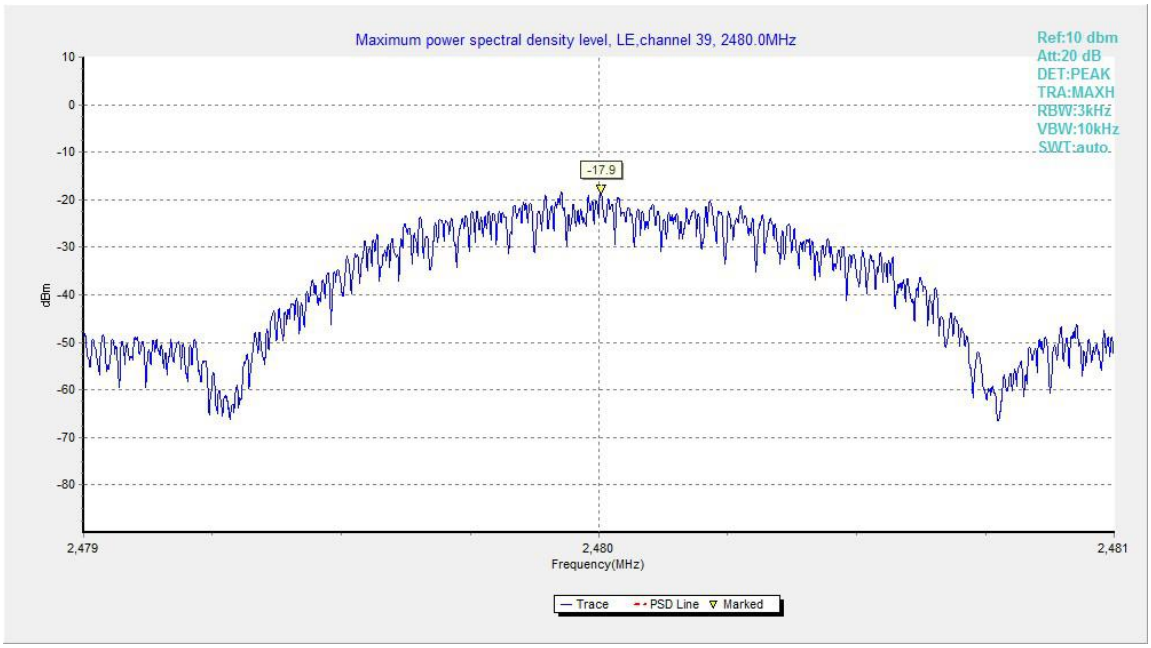

Fig.25. Maximum Power Spectral Density Level Function: GFSK, 2480 MHz

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A.8. AC Powerline Conducted Emission

Method of Measurement: See ANSI C63.10-clause 6.2

1. the one EUT cable configuration and arrangement and mode of operation that produced the emission with the highest amplitude relative to the limit is selected for the final measurement, while applying the appropriate modulating signal to the EUT.
2. If the EUT is relocated from an exploratory test site to a final test site, the highest emissions shall be re-maximized at the final test location before final ac power-line conducted emission measurements are performed.
3. The final test on all current-carrying conductors of all of the power cords to the equipment that comprises the EUT (but not the cords associated with other non-EUT equipment in the system) is then performed for the full frequency range for which the EUT is being tested for compliance without further variation of the EUT arrangement, cable positions, or EUT mode of operation.
4. If the EUT is comprised of equipment units that have their own separate ac power connections, e.g., floor-standing equipment with independent power cords for each shelf that are able to connect directly to the ac power network, each current-carrying conductor of one unit is measured while the other units are connected to a second (or more) LISN(s). All units shall be separately measured. If a power strip is provided by the manufacturer, to supply all of the units making up the EUT, only the conductors in the power cord of the power strip shall be measured.
5. If the EUT uses a detachable antenna, these measurements shall be made with a suitable dummy load connected to the antenna output terminals; otherwise, the tests shall be made with the antenna connected and, if adjustable, fully extended. When measuring the ac conducted emissions from a device that operates between 150 kHz and 30 MHz a non-detachable antenna may be replaced with a dummy load for the measurements within the fundamental emission band of the transmitter, but only for those measurements.36 Record the six highest EUT emissions relative to the limit of each of the current-carrying conductors of the power cords of the equipment that comprises the EUT over the frequency range specified by the procuring or regulatory agency. Diagram or photograph the test setup that was used. See Clause 8 for full reporting requirements.

Test Condition

Voltage（V）	Frequency（Hz）
120	60

Measurement Result and limit:

Bluetooth (Quasi-peak Limit)

Frequency range (MHz)	Quasi-peak Limit (dBμV)	Conclusion
0.15 to 0.5	66 to 56	P
0.5 to 5	56	
5 to 30	60	
NOTE: The limit decreases linearly with the logarithm of the frequency in the range 0.15 MHz to 0.5 MHz.		

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Bluetooth (Average Limit)

Frequency range (MHz)	Average Limit (dBμV)	Conclusion
0.15 to 0.5	56 to 46	P
0.5 to 5	46	
5 to 30	50	
NOTE: The limit decreases linearly with the logarithm of the frequency in the range 0.15 MHz to 0.5 MHz.		

The measurement is made according to ANSI C63.10

Conclusion: PASS

Test graphs as below:

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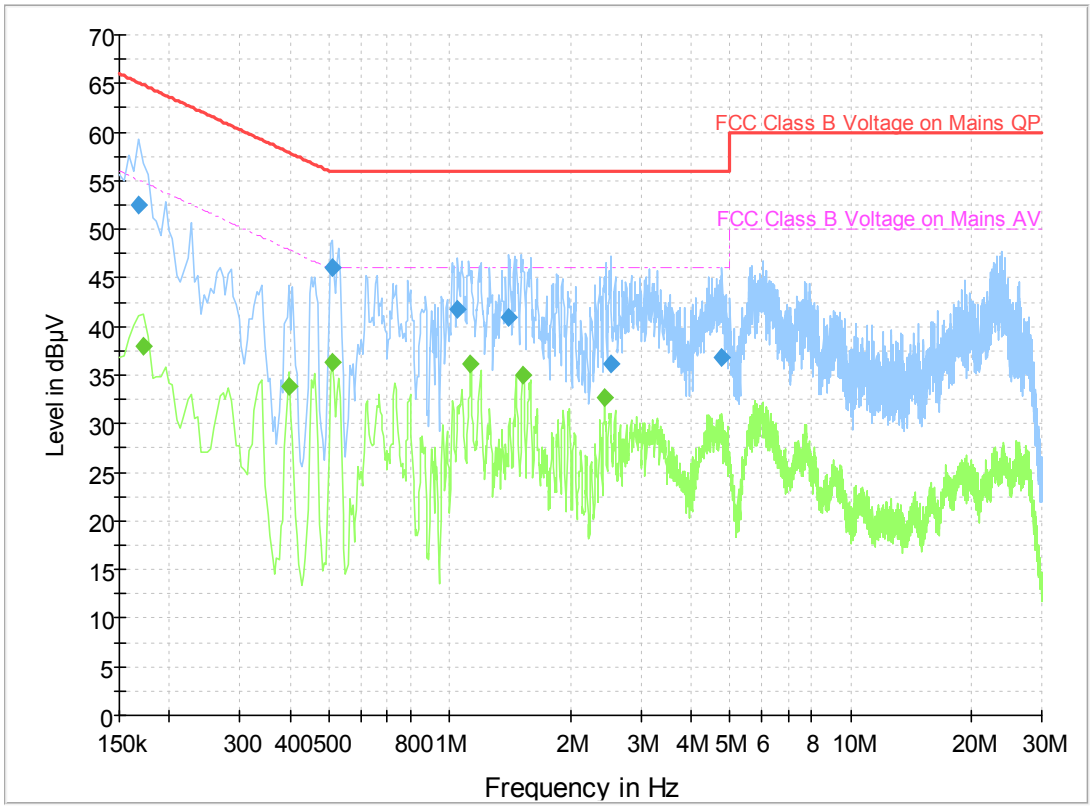
Traffic for Set.11:



Final Result 1

Frequency (MHz)	QuasiPeak (dBµV)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin (dB)	Limit (dBµV)
0.168000	52.5	2000.0	9.000	On	L1	26.8	12.5	65.1
0.510000	46.1	2000.0	9.000	On	L1	19.8	9.9	56.0
1.045500	41.8	2000.0	9.000	On	L1	19.7	14.2	56.0
1.405500	40.9	2000.0	9.000	On	L1	19.6	15.1	56.0
2.526000	36.2	2000.0	9.000	On	L1	19.6	19.8	56.0
4.785000	36.8	2000.0	9.000	On	L1	19.6	19.2	56.0

Final Result 2

Frequency (MHz)	Average (dBµV)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin (dB)	Limit (dBµV)
0.172500	38.0	2000.0	9.000	On	L1	25.8	16.8	54.8
0.397500	33.9	2000.0	9.000	On	L1	19.8	14.0	47.9
0.510000	36.2	2000.0	9.000	On	L1	19.8	9.8	46.0
1.126500	36.1	2000.0	9.000	On	L1	19.7	9.9	46.0
1.527000	35.0	2000.0	9.000	On	L1	19.6	11.0	46.0
2.436000	32.6	2000.0	9.000	On	L1	19.6	13.4	46.0

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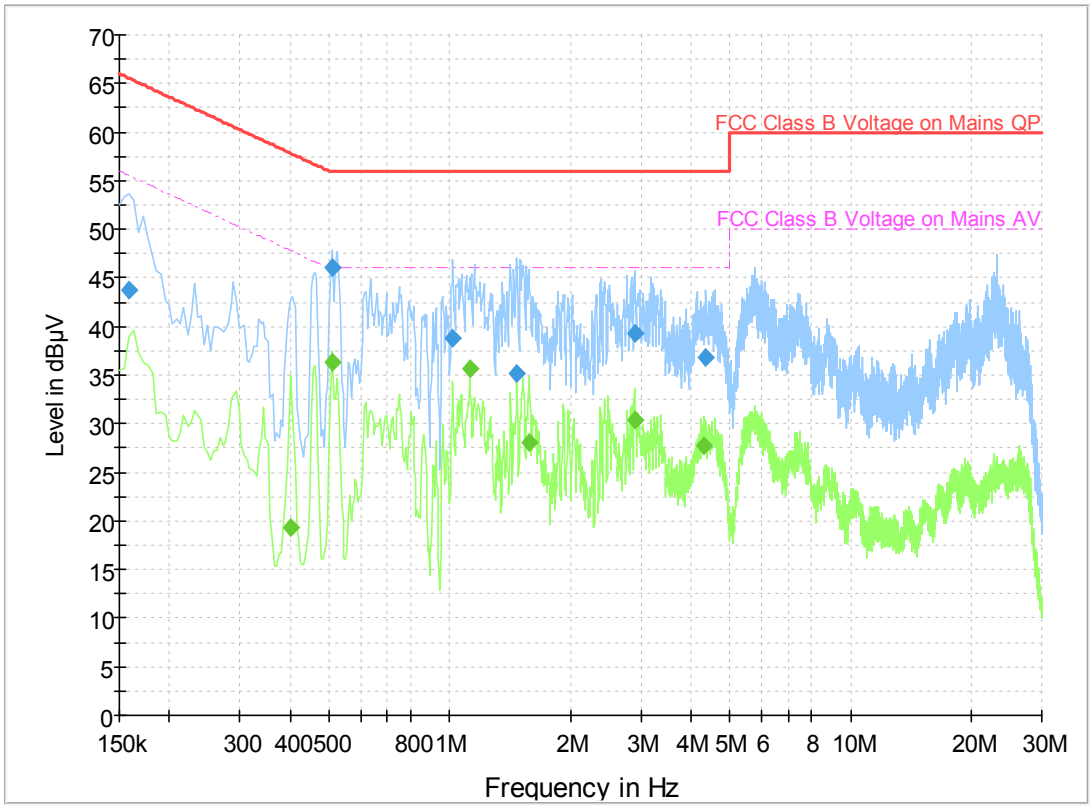
Idle for Set.11:



Final Result 1

Frequency (MHz)	QuasiPeak (dBµV)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin (dB)	Limit (dBµV)
0.159000	43.7	2000.0	9.000	On	L1	28.7	21.8	65.5
0.510000	46.1	2000.0	9.000	On	L1	19.8	9.9	56.0
1.018500	38.8	2000.0	9.000	On	L1	19.7	17.2	56.0
1.473000	35.2	2000.0	9.000	On	L1	19.6	20.8	56.0
2.890500	39.3	2000.0	9.000	On	L1	19.6	16.7	56.0
4.366500	36.8	2000.0	9.000	On	L1	19.6	19.2	56.0

Final Result 2

Frequency (MHz)	Average (dBµV)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin (dB)	Limit (dBµV)
0.402000	19.3	2000.0	9.000	On	L1	19.8	28.6	47.8
0.510000	36.2	2000.0	9.000	On	L1	19.8	9.8	46.0
1.122000	35.6	2000.0	9.000	On	L1	19.7	10.4	46.0
1.576500	28.1	2000.0	9.000	On	L1	19.6	17.9	46.0
2.890500	30.3	2000.0	9.000	On	L1	19.6	15.7	46.0
4.308000	27.7	2000.0	9.000	On	L1	19.6	18.3	46.0

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ANNEX B: Accreditation Certificate

United States Department of Commerce
National Institute of Standards and Technology

NVLAP®

Certificate of Accreditation to ISO/IEC 17025:2005

NVLAP LAB CODE: 600118-0

Telecommunication Technology Labs, CAICT
Beijing
China

is accredited by the National Voluntary Laboratory Accreditation Program for specific services, listed on the Scope of Accreditation, for:

Electromagnetic Compatibility & Telecommunications

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2005. This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communique dated January 2009).

2019-09-26 through 2020-09-30
Effective Dates

DEPARTMENT OF COMMERCE · UNITED STATES OF AMERICA

For the National Voluntary Laboratory Accreditation Program

*****END OF REPORT*****

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